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N-channel TrenchMOS logic level FET

11 September 2012

Product data sheet

1. Product profile

1.1 General description

Logic level N-channel MOSFET in a SOT78 package using TrenchMOS technology. This product has been designed and qualified to AEC Q101 standard for use in high performance automotive applications.

1.2 Features and benefits

- AEC Q101 compliant
- Repetitive avalanche rated
- Suitable for thermally demanding environments due to 175 °C rating
- True logic level gate with Vgst(th) rating of greater than 0.5V at 175 °C

1.3 Applications

- 12 V Automotive systems
- Motors, lamps and solenoid control
- Start-Stop micro-hybrid applications
- Transmission control
- Ultra high performance power switching

1.4 Quick reference data

Table 1. Qu	lick reference data						
Symbol	Parameter	Conditions		Min	Тур	Max	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C		-	-	40	V
I _D	drain current	V _{GS} = 5 V; T _{mb} = 25 °C; <u>Fig. 1</u>	[1]	-	-	100	А
P _{tot}	total power dissipation	T _{mb} = 25 °C; <u>Fig. 2</u>		-	-	234	W
Static charac	teristics						
R _{DSon}	drain-source on-state resistance	V _{GS} = 5 V; I _D = 25 A; T _j = 25 °C; <u>Fig. 11</u>		-	2.7	3.2	mΩ
Dynamic cha	racteristics	·					
Q _{GD}	gate-drain charge	V _{GS} = 5 V; I _D = 25 A; V _{DS} = 32 V; Fig. 13; Fig. 14		-	25.8	-	nC

[1] Continuous current is limited by package.





N-channel TrenchMOS logic level FET

2. Pinning information

Table 2.	Pinning	information		
Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate	mb	D
2	D	drain		
3	S	source		G C C C C C C C C C C C C C C C C C C C
mb	D	mounting base; connected to drain		mbb076 S
			TO-220AB (SOT78A)	

3. Ordering information

Table 3. Ordering information							
Type number	Package						
	Name	Description	Version				
BUK953R2-40E	TO-220AB	plastic single-ended package; heatsink mounted; 1 mounting hole; 3-lead TO-220AB	SOT78A				

4. Marking

Table 4. Marking codes	
Type number	Marking code
BUK953R2-40E	BUK953R2-40E

5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Мах	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C		-	40	V
V _{DGR}	drain-gate voltage	R _{GS} = 20 kΩ		-	40	V
V _{GS}	gate-source voltage	T _j ≤ 175 °C; DC		-10	10	V
		$T_j \le 175 \text{ °C}; \text{ Pulsed}$	[1][2]	-15	15	V
I _D	drain current	T _{mb} = 25 °C; V _{GS} = 5 V; <u>Fig. 1</u>	[3]	-	100	А
		T _{mb} = 100 °C; V _{GS} = 5 V; <u>Fig. 1</u>	[3]	-	100	А

BUK953R2-40E

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BUK953R2-40E

N-channel TrenchMOS logic level FET

Symbol	Parameter	Conditions		Min	Мах	Unit
I _{DM}	peak drain current	T_{mb} = 25 °C; pulsed; $t_p \le 10 \ \mu$ s; Fig. 4		-	781	А
P _{tot}	total power dissipation	T _{mb} = 25 °C; <u>Fig. 2</u>		-	234	W
T _{stg}	storage temperature			-55	175	°C
Tj	junction temperature			-55	175	°C
Source-drai	in diode					
I _S	source current	T _{mb} = 25 °C	[3]	-	100	А
I _{SM}	peak source current	pulsed; $t_p \le 10 \ \mu s$; $T_{mb} = 25 \ ^{\circ}C$		-	781	А
Avalanche	ruggedness					
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	$\begin{split} I_D &= 100 \text{ A}; \text{ V}_{sup} \leq 40 \text{ V}; \text{ R}_{GS} = 50 \Omega; \\ \text{ V}_{GS} &= 5 \text{ V}; \text{ T}_{j(init)} = 25 \ ^{\circ}\text{C}; \text{ unclamped}; \\ \hline \text{Fig. 3} \end{split}$	[4][5]	-	419	mJ

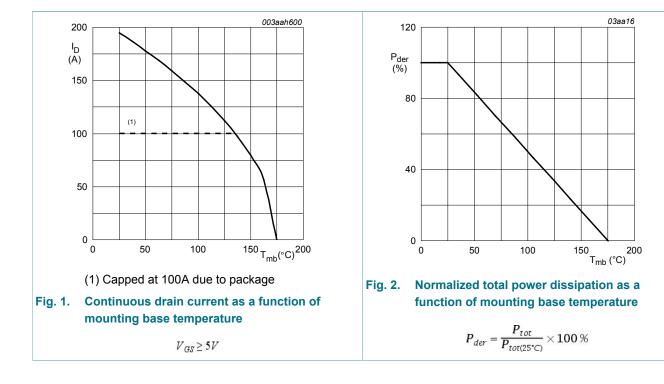
Accumulated pulse duration up to 50 hours delivers zero defect ppm [1]

Significantly longer life times are achieved by lowering $\rm T_{i}$ and or $\rm V_{GS}$ [2]

Continuous current is limited by package. [3]

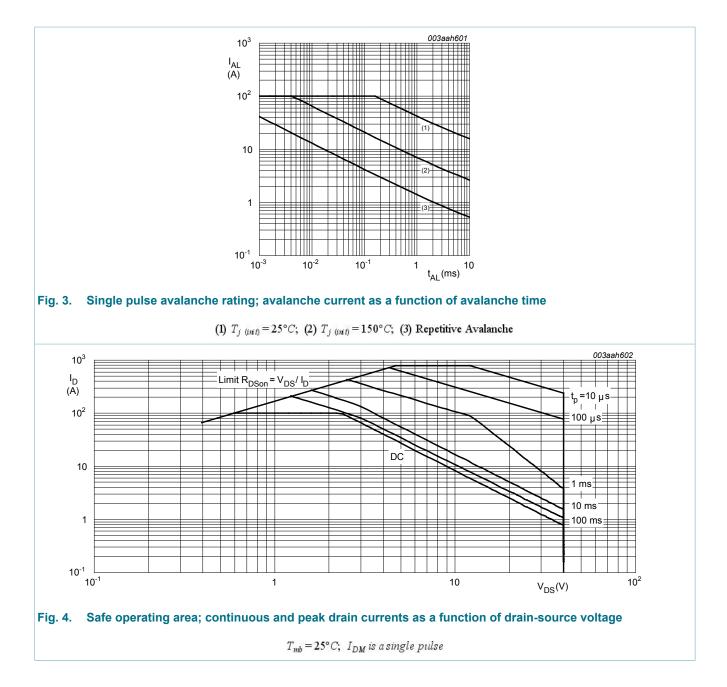
Single-pulse avalanche rating limited by maximum junction temperature of 175 °C. [4] [5]

Refer to application note AN10273 for further information.



BUK953R2-40E

N-channel TrenchMOS logic level FET

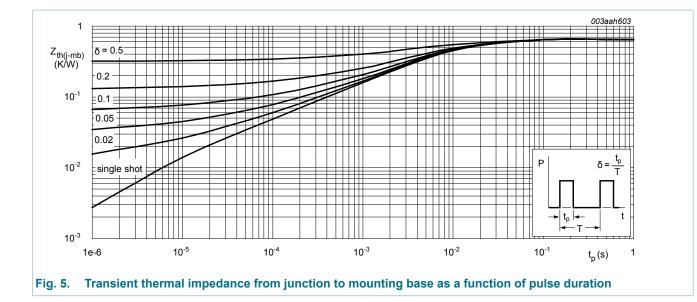


6. Thermal characteristics

Table 6. Thermal characteristics							
Symbol	Parameter	Conditions		Min	Тур	Max	Unit
R _{th(j-mb)}	thermal resistance from junction to mounting base	<u>Fig. 5</u>		-	-	0.64	K/W
R _{th(j-a)}	thermal resistance from junction to ambient	vertical in still air		-	60	-	K/W

BUK953R2-40E

N-channel TrenchMOS logic level FET

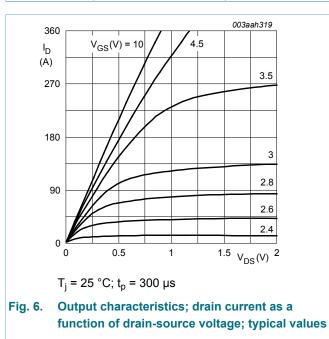


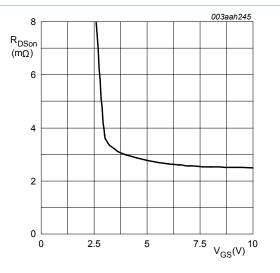
Characteristics 7.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static chara	octeristics					
V _{(BR)DSS}	drain-source	I_D = 250 µA; V_{GS} = 0 V; T_j = 25 °C	40	-	-	V
	breakdown voltage	I_D = 250 µA; V_{GS} = 0 V; T_j = -55 °C	36	-	-	V
V _{GS(th)}	gate-source threshold voltage	$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 25 \text{ °C};$ Fig. 9; Fig. 10	1.4	1.7	2.1	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = -55 \text{ °C};$ Fig. 9	-	-	2.45	V
		I_D = 1 mA; V_{DS} = V_{GS} ; T_j = 175 °C; Fig. 9	0.5	-	-	V
I _{DSS} d	drain leakage current	V_{DS} = 40 V; V_{GS} = 0 V; T_j = 25 °C	-	0.06	1	μA
		V _{DS} = 40 V; V _{GS} = 0 V; T _j = 175 °C	-	-	500	μA
I _{GSS}	gate leakage current	V_{GS} = 10 V; V_{DS} = 0 V; T_j = 25 °C	-	2	100	nA
	gate leakage current	V_{GS} = -10 V; V_{DS} = 0 V; T_j = 25 °C	-	2	100	nA
R _{DSon}	drain-source on-state	V _{GS} = 5 V; I _D = 25 A; T _j = 25 °C; <u>Fig. 11</u>	-	2.7	3.2	mΩ
	resistance	V _{GS} = 10 V; I _D = 25 A; T _j = 25 °C; Fig. 11	-	2.4	2.8	mΩ
		V _{GS} = 5 V; I _D = 25 A; T _j = 175 °C; Fig. 12; Fig. 11	-	-	6.1	mΩ
Dynamic ch	aracteristics				_	
Q _{G(tot)}	total gate charge	I_D = 25 A; V_{DS} = 32 V; V_{GS} = 5 V;	-	69.5	-	nC
Q _{GS}	gate-source charge	Fig. 13; Fig. 14	-	16.1	-	nC

N-channel TrenchMOS logic level FET

Symbol	Parameter	Conditions	Min	Тур	Мах	Unit
Q _{GD}	gate-drain charge		-	25.8	-	nC
C _{iss}	input capacitance	V _{GS} = 0 V; V _{DS} = 25 V; f = 1 MHz;	-	6870	9150	pF
C _{oss}	output capacitance	T _j = 25 °C; <u>Fig. 15</u>	-	875	1050	pF
C _{rss}	reverse transfer capacitance		-	450	620	pF
t _{d(on)}	turn-on delay time	V_{DS} = 30 V; R _L = 1.2 Ω; V _{GS} = 5 V; R _{G(ext)} = 5 Ω	-	42	-	ns
t _r	rise time		-	73	-	ns
t _{d(off)}	turn-off delay time		-	114	-	ns
t _f	fall time		-	76	-	ns
L _D	internal drain inductance	from upper edge of drain mounting base to center of die	-	2.5	-	nH
L _S	internal source inductance	from source lead to source bonding pad	-	7.5	-	nH
Source-dra	in diode					,
V _{SD}	source-drain voltage	I_{S} = 25 A; V_{GS} = 0 V; T_{j} = 25 °C; <u>Fig. 16</u>	-	0.8	1.2	V
t _{rr}	reverse recovery time	I_{S} = 20 A; dI_{S}/dt = -100 A/µs; V _{GS} = 0 V;	-	40	-	ns
Qr	recovered charge	V _{DS} = 25 V	-	47	-	nC



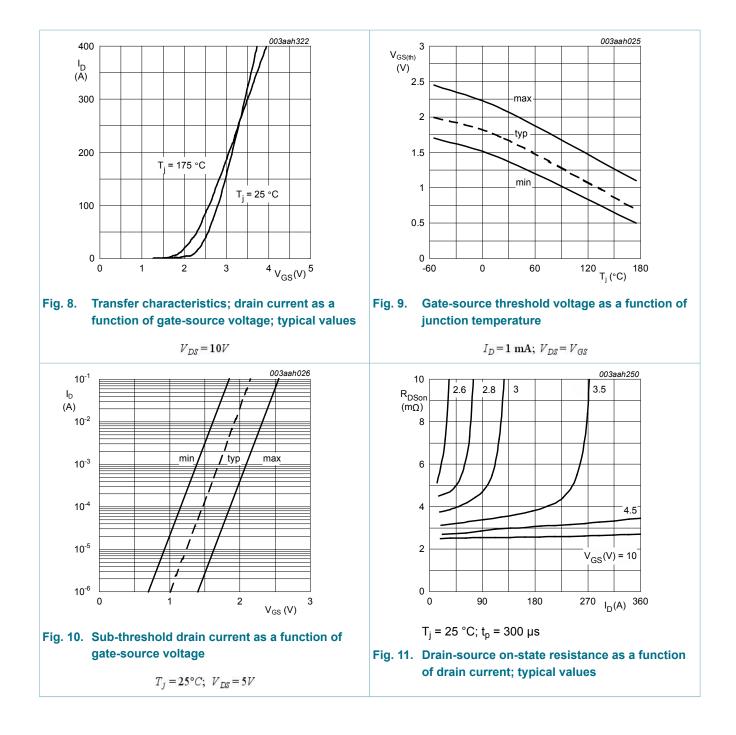




 $T_j = 25^{\circ}C; I_D = 25A$

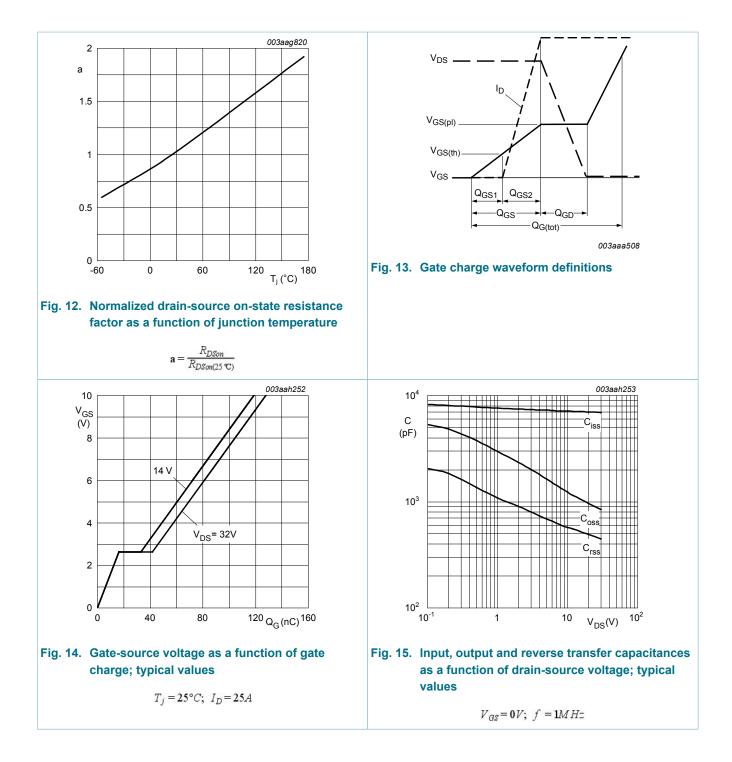
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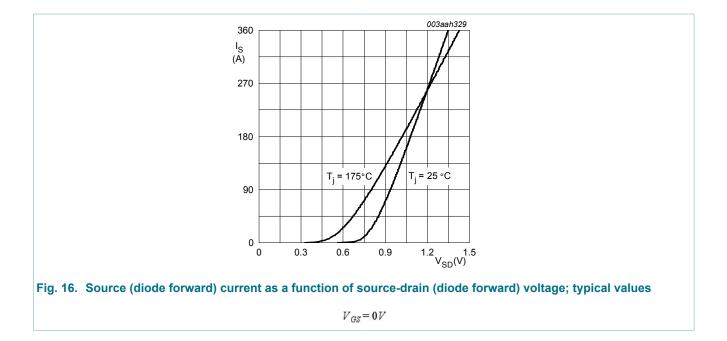
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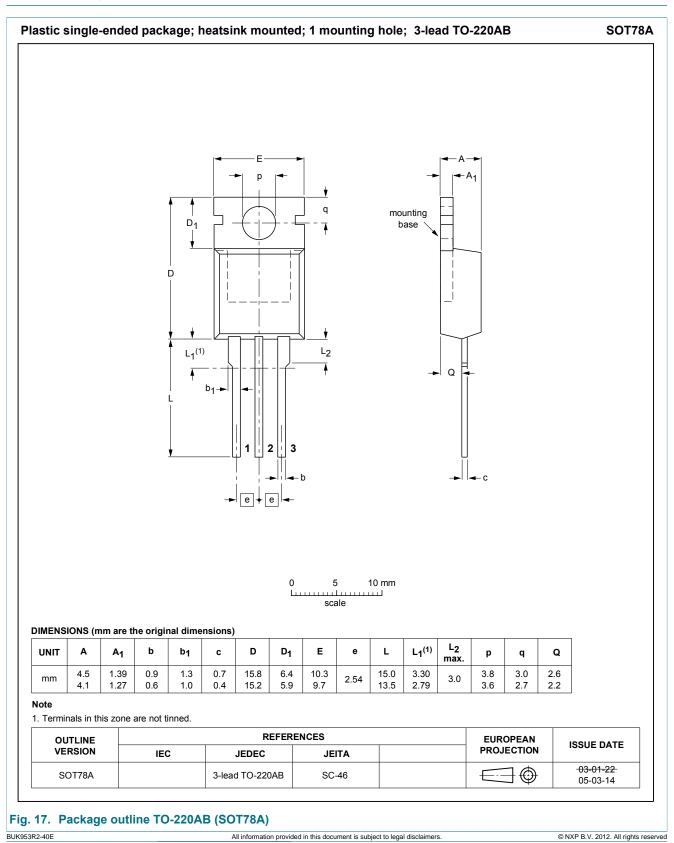
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Package outline 8.



Product data sheet

N-channel TrenchMOS logic level FET

9. Legal information

9.1 Data sheet status

Document status [1][2]	Product status [<u>3]</u>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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10. Contents

Product profile	1
General description	1
Features and benefits	1
Applications	1
Quick reference data	1
Pinning information	2
Ordering information	2
Marking	2
Limiting values	2
Thermal characteristics	4
Characteristics	5
Package outline1	0
Legal information1	1
Data sheet status 1	1
Definitions1	1
Disclaimers1	1
Trademarks 12	2
	Product profile General description General description Features and benefits Applications Quick reference data Pinning information Ordering information Ordering information Marking Limiting values Thermal characteristics Characteristics Package outline Data sheet status 1 Definitions 1 Disclaimers 1 Trademarks 12

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